

Product Specification

Twin Leaf Connector

1. SCOPE

1.1. Content

This specification covers the performance requirements for the AMP* Twin Leaf mother board connector. This connector is a multi-contact, edge board type assembly for wrap or solder applications. Connectors are available having .100, .125, .150 or .156 inch centerline spacing between adjacent contacts and .200 inch spacing between contact rows.

1.2. Oualification

When testing or inspecting the subject product, this document shall always be supported by the applicable product drawing and by 109-9000. Packaging Components Division Connector Test Methods. In case of conflict the order of document precedence is as follows:

- A. Product Drawing
- B. This Product Specification
- C. 109-9000: Packaging Components Division Connector Test Methods

2. APPLICABLE DOCUMENTS

- 2.1. Applicable portions of the following documents form a part of the manufacturing control of this product.
 - A. MIL-G-45204: Gold Plating. Electrodeposited.
- 2.2. The following documents describe testing of this product:
 - A. 109-9000: Packaging Components Division Connector Test Methods.
 - B. MIL-STD-1344: Test Methods for Electrical Connectors.

3. PERFORMANCE REQUIREMENTS

- 3.1. Ratings
 - A. Current: 3.0 amperes maximum per contact
 - B. Temperature: -55° to 105°C



3.2. Test Requirements and Procedures Summary

Test Description	Requirements	Procedure	
Examination of Product	Meets requirements of drawing	Dimensional and visual	
Termination Resistance, Low Level	.010 ohms maximum	50 mv maximum open circuit, 100 ma maximum short circuit.	
Termination Resistance Rated Current	.010 ohms maximum 3 amperes		
Insulation Resistance	5000 megohms minimum initial; 1000 megohms minimum final	500 vdc, unmated,	
Dielectric Withstanding Voltage	Test Voltage vrms Centerline Spacing Altitude .100/.125 .150/.156 Sea Level 1000 1500 50,000 ft. 400 600 70,000 ft. 230 400 5 ma maximum leakage	Unmated connectors, test between adjacent contacts, and contacts to mounting hardware.	
Contact Separation Force	1.0 ounce minimum per contact pair	Size 3 times with max imum thickness gage .070; check with min- imum thickness gage .054.	
Connector Mating Force	16.0 ounces maximum average per contact pair	Maximum thickness gage. 070.	
Durability	No evidence of physical damage; meet contact separation force and termination resistance rated current.	100 cycles mating and unmating with maximum thickness gage .070.	
Temperature Cycling Vibration	No physical damage. No interruption of continuity greater than 1 microsecond; no physical damage	-55° to 105° C Series wired and mated with printed circuit board. 10 to 55 Hz; .06 inch double amplitude, 100 ma current.	

Figure 1 (cont)

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Test Description	Requirements	Procedure	
Shock (Specified Pulse)	No interruption of continuity greater than 1 microsecond; no physical damage.	Series wired and mated with printed circuit board. 100 G's, 6 milliseconds, sawtooth. 100 ma current.	
Humidity	Remove from the chamber and air dry at room ambient conditions for 4 hours before electrical tests. Meet insulation resistance final and dielectric withstanding yoltage.	90-95% RH, 96 hours 40° C; unmated.	

Figure 1 (end)

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3.3. Connector Tests and Sequence

	MIL-STD-1344	109-9000	Test Sequence	
Test	Method	Requirement Paragraph	1	2
Examination of Product		5.1.	X	Х
Connector Mating Force	2013.1	5.8.		Х
Termination Resistance, Low Level (b)	3002,1	5,2,	х	х
Termination Resistance, Rated Current (b)	3004.1	5.3.	х	х
Insulation Resistance	3003.1	5,4.	X	
Dielectric Withstanding Voltage	3001.1 cond I, III & IV	5,5,	Х	
Contact Separation Force	2014	5.7.		X
Durability Contact Separation Force Termination Resistance, Rated Current	2016	5.10.	Х	x
Temperature Cycling (a)	1003.1, cond A	5.11.	Х	•
Vibration	2005.1, cond I	5.12.		X
Shock (Specified Pulse)	2004.1, cond G	5.13.		X
Humidity	1002.2 Type I, cond B	5,14.	x	
Insulation Resistance Dielectric Withstanding Voltage				
Termination Resistance, Low Level (b)	3002.1	5,2,	х	х
Termination Resistance, Rated Current (b)	3004.1	5.3.	Х	Х

(a) Upper temperature limit 105°C

(b) See Figure 3

Figure 2

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3.4. Selection of Test Samples

- A. Test samples shall consist of 6 connectors containing the largest number of positions of each connector type offered 3 each Test Sequence 1 and Test Sequence 2. Two additional specimens shall be selected from the least number of positions offered and tested to Test Sequence 2.
- B. Connectors shall be mounted in accordance with AMP Instruction Sheet 7498. Card guides, screws, keys and other hardware normally used with the connectors shall be included with the test specimens.

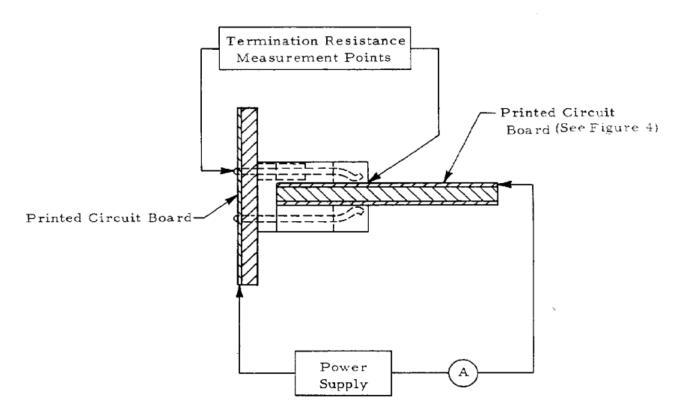
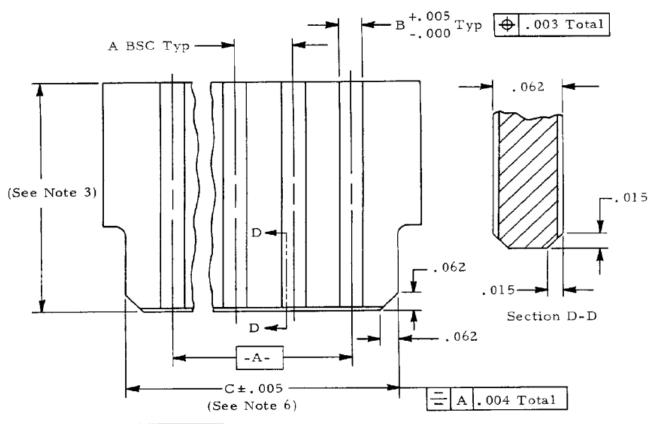


Figure 3

Typical Termination Resistance Measurement Points for Board to Board Type Connectors

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Connector Contact Spacing	A BSC	В
.100	.100	. 052
.125	.125	.078
.150	.150	.094
.156	.156	. 094

Notes:

- 1. Dimensions are in inches.
- Unless otherwise specified, tolerance is ±. 005.
- 3. The test card shall extend 4.00 \pm .02 from the receptacle after insertion.
- 4. Number of contacts shall be the same as on the corresponding printed wiring connector.
- Printed circuit test board shall be 2 oz copper and gold over nickel plated per MIL-STD-275.
- 6. This dimension shall be the minimum connector card slot length minus .008.
- 7. Conductor configuration optional beyond card slot depth.
- 8. Printed wiring shall be identical on both sides.

Figure 4
Printed Circuit Board

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